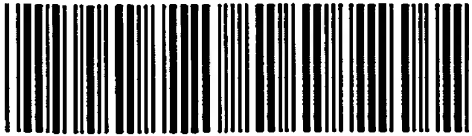


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/730,075	CHEN, WEN-KUAN	
	Examiner	Art Unit	
	Thomas R. Hannon	3682	

SEARCHED			
Class	Subclass	Date	Examiner
above	update	9/15/2005	TRH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR